Notice of References Cited

Application/Control No. 09/935,129	Reexamination	Applicant(s)/Patent Under Reexamination SCHWEITZER ET AL.		
Examiner	Art Unit			
Hai V. Nguyen	2142	Page 1 of 1		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,470,386	10-2002	Combar et al.	709/224
	В	US-6,308,148	10-2001	Bruins et al.	703/27
	С	US-6,272,126	08-2001	Strauss et al.	370/352
	D	US-6,230,203	05-2001	Koperda et al.	709/229
	E	US-6,157,648	12-2000	Voit et al.	370/401
	F	US-6,104,704	08-2000	Buhler et al.	370/252
	G	US-6,032,147	02-2000	Williams et al.	707/101
	Н	US-5,958,010	09-1999	Agarwal et al.	709/224
	1	US-5,781,729	07-1998	Baker et al.	709/230
	J	US-5,778,350	07-1998	Adams et al.	707/1
	К	US-5,557,746	09-1996	Chen et al.	709/202
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

	TOKEIGH TATEM DOCUMENTO					
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	Р					
	Q					
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	s					
	Т					

NON-PATENT DOCUMENTS

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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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